

Application/Control No.	Applicant(s)/Patent under Reexamination	
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Examiner	Art Unit	
Daniel Pan	2183	

SEARCHED					
Class	Subclass	Date	Examiner		
712	4 22	2/7/2006	DP .		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
west pgp uspat jpoabs epoabs derwent ibm ieee npl 710/60 trans. data 712/225 tran. data	2/7/2006	DP